

Thank You

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ACCELERATED THERMAL AGING



- This Simulates deterioration due to temperature exposure
- Instrument is kept at elevated temperature in a thermal chamber for time as decided by Arrrhenius equation
 - ✓ Ambient temperature is 45⁰ C
 - ✓ Instrument Life is 10 years

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- √ Thermal Chamber Temperature kept at 85° C
- ✓ Duration of Testing will be152 days

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THERMAL CHAMBER





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LOCA TEST CHAMBER





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SEISMIC SHAKE TABLE





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TEST FACILITIES AVAILABLE IN INDIA

RSD BARC

- ✓ Radiation Ageing, Thermal Ageing, LOCA test
- R&D Centre, TAPS 3&4
 - ✓ Radiation Aging, Thermal Ageing, LOCA test
- ERDA Vadodara
 - ✓ Thermal Ageing and LOCA test
- Test facility for LOCA and MSLB is being setup at IIT, Mumbai

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Shake Table test facilities in India

■ ERDA, Baroda : 150 Kg Uniaxial shaketable (0.6m x 0.6m

■ ECIL, Hyderabad: 100 Kg Uniaxial shaketable

 \checkmark (0.7m x 0.7m), 35 cm stroke length

■ SERC, Chennai : 30 T Triaxial shaketable

√ (4m x 4m), 4 vertical & 4 hori. Actuators

■ CPRI, Bangalore : 10 T Triaxial table

 \checkmark (3m x 3m), 4 ver & 4 hor actuators

■ IGCAR, : 10 T Triaxial table

■ Kalpakkam : (4m x 4m), 4 ver & 4 hor actuators

■ IIT Roorkee : 20 T Biaxial shaketable

√ (3.5m x 3.5m), 2 ver & 1 hor actuator



OPERATING EXPERIENCES WITH PROGRAMMABLE LOGIC CONTROLLER (PLC) SYSTEM IN INDIAN NUCLEAR POWER PLANTS.

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OVERVIEW



- > INTRODUCTION
- > PLC ARCHITECTURE
- > CHALLENGES ASSOCIATED WITH PLCs
 - **✓** Performance
 - **✓** Obsolescence
- > CONCLUSION



INTRODUCTION

Systems in Indian NPPs are categorized based on their significance to nuclear safety.

- Safety Critical (Class IA)
- Safety Related(Class IB and IC)
- Not Important to Nuclear Safety (Class NINS)

PLCs are used in IB and NINS applications.

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Usage of PLCs in NPPs

- Control of various process interlocks and control functions (Station-PLC)
- Control of Main and Emergency airlocks (Airlock PLC)
- Dryer control (Dryer PLC)
- Emergency transfer of load (EMTR PLC).

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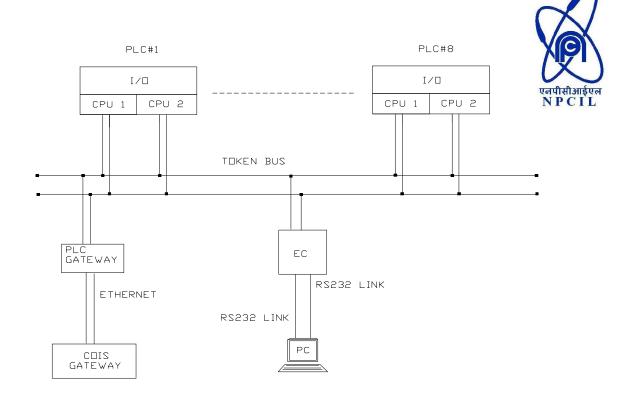
PLC ARCHITECTURE

Two kinds of architecture are employed in PLC implementation:-

- Dual processor hot standby where each PLC has two redundant processors with common I/Os
- Dual computer hot standby where each PLC has single processor but one PLC is standby to other

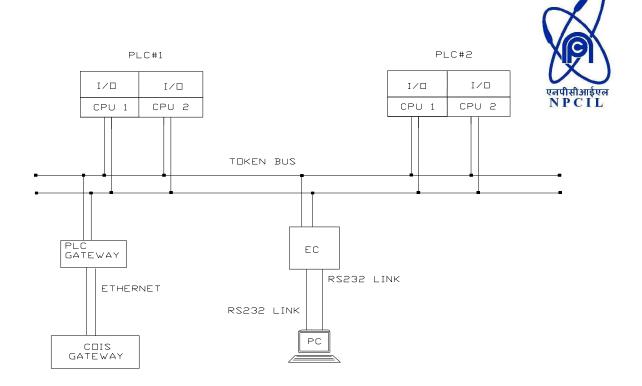
A number of such PLCs are connected through dual redundant token bus networks, and exchange data and information necessary for generation of outputs. In each network an engineering work station serves as an operator interface.

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PLC ARCHITECTURE WITH COMMON I/O AND REDUNDANT PROCESSORS

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PLC ARCHITECTURE WITH REDUNDANT I/O AND REDUNDANT PLCs

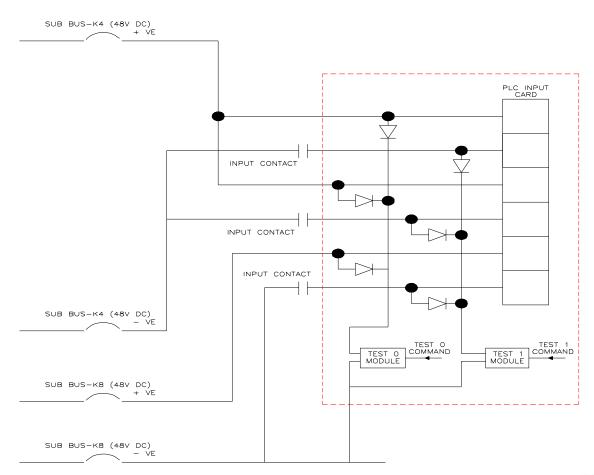
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I) PERFORMANCE

a) Spurious ground fault indication in 48 V DC control power supply

This was attributed to high off-state current of FIT (Finite Impulse Test) modules. It has been addressed by using low off state current FIT modules having low leakage current, by reducing FIT frequency and by providing dedicated built-in field input interrogation power supply.



SIMPLIFIED ARRANGEMENT IN FIELD INPUT CARD



(b) PLCs going Out of network

- observed in all the plants
- impact was significant in NPPs where LAN was also used for sharing control signals among the PLC nodes (i.e. information required for generating outputs used in controlling various equipments)
- resulting into process disturbances.

The problem was attributed to:

- Longer length of LAN cable
- Weak signal strength
- Improper Grounding of LAN cable shields

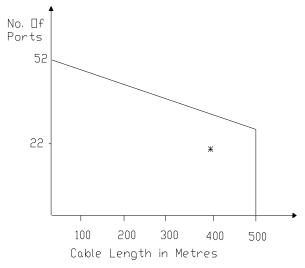
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- No. of nodes on LAN is 22 and the length of LAN cable was around 400 meters.
- Stretching and bending of cable in cable trays and improper grounding of the cable shield,
- The minimum signal strength (10dBmV min.) at the receiving node was not available.



RELATION BETWEEN ON OF NODES AND CABLE LENGTH

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Modifications:



- LAN network is split into number of smaller networks.
- Maintaining the bending radius of trunk cable > 7 inches
- Laying of LAN cable in metallic conduit
- Multipoint grounding of LAN cable as per IEEE-1050.
- Validation of LAN

To avoid the disturbance on loads due to communication failure, the use of LAN is restricted to information function only.

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After carrying out the above modifications, the LAN parameters were measured and results are summarized.

LAN Parameters		Before modification	After modification & with multipoint grounding
Signal attenuation		36.13 dB	4.98 dB
Noise	Peak	+4 dBmV	-10 dBmV
	Average	-19 dBmV	-20 dBmV
Return Loss		-30.01 dB	-31.82 dB

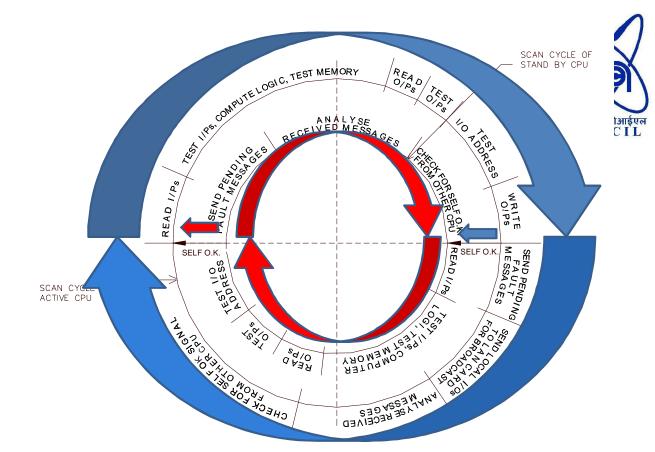
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(c) Halting of CPU



- One CPU halting in dual processor hot standby PLC configuration.
- The problem attributed to loss of synchronization between two running CPUs.
- Loss of synchronization between the running CPUs occurred due to elongation of cycle time of PLC.
 Because of this, each CPU considered other CPU faulty and tried to acquire the bus leading to bus contention and subsequent halting of one CPU.

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SCAN CYCLE OF A CPU

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Modification:

To address the CPU halting problem, PLC software is modified to implement the fixed period of execution for the scan task so that the communication task can be kept at lower priority.

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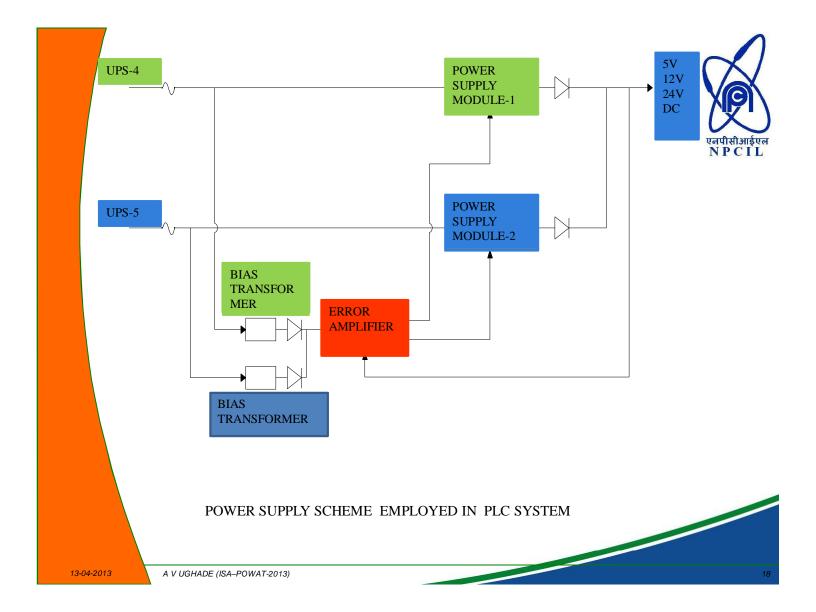


d) Power Supplies of PLC

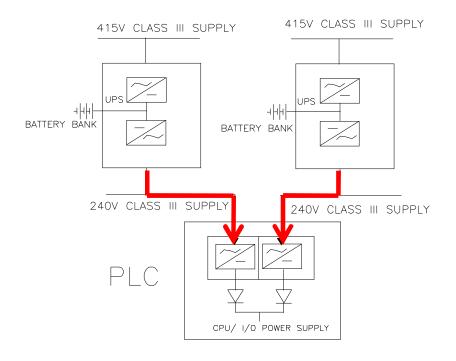
In the previous design of power supply, common circuit was present for paralleled power supply modules & there was failure in the common circuit.

In the new design power supplies are made fully independent without any common circuit.

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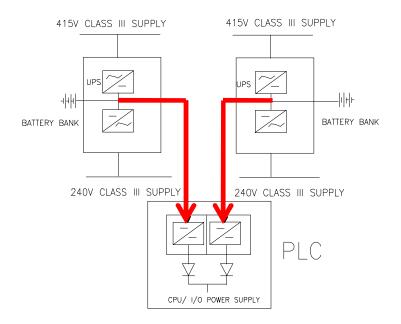
PLC POWER SUPPLY SCHEME (OLD)

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7.





MODIFIED PLC POWER SUPPLY SCHEME

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Modifications:



- •DC to DC SMPS is used in place of AC to DC SMPS
- •
- •Independent error amplifier is used to ensure current sharing.
- •Source power supply to DC to DC SMPS is taken from intermediate DC bus of UPS which has a battery back-up.

Failure of any UPS will not lead to unavailability source power supply to DC to DC SMPS.

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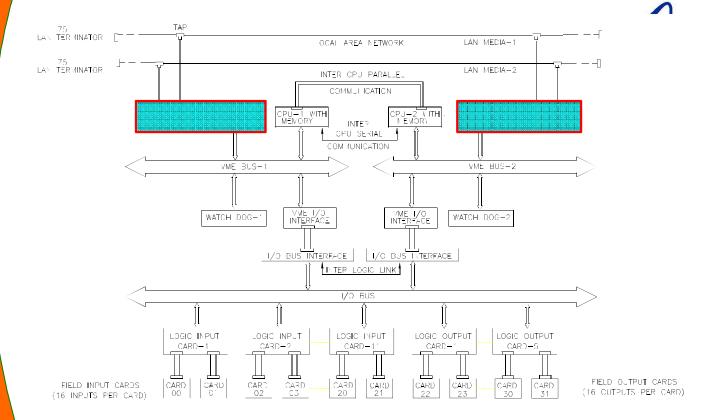
II) OBSOLESCENCE

Hardware for following boards not available.

- TBC VME Used in Token Bus
- TBC MODEM

To overcome obsolescence design modification is carried out to replace token bus with dual Ethernet LAN. This Ethernet LAN is retrofitted in EMTR PLC and Airlock PLCs. Based on this performance, the implementation of Ethernet network is being considered for other PLCs also.

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A TYPICAL PLC IN NPPs

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CONCLUSION

- PLC system is running satisfactorily after carrying out all the above modifications in the existing operating NPPs.
- Up-gradation of Token Bus with Ethernet is taken up to address obsolescence.

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System Reliability and Updation

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Abstract

- Reliability Modeling of system based on Bayesian Network
- Limitations of traditional reliability analysis
- Fault Tree Diagram -> Bayesian network
- Advantages
- Impact of change of subsystem reliability change on other subsystems/system
- Emergency Core Cooling System

Introduction

- Traditional techniques assumption:
- -all the failures are independent and the rate of failure is constant (using BN it is possible to include local independencies into the model, by directly specifying the causes that influences a given effect)
- -due to the approximations in the computational model and the limited statistical data on the input variables, there may be uncertainty in this computation

Introduction contd...

- -BN has power of predictive (fwd) and diagnostic (bwd)analysis; fwd: P(occ. of any node is cal on basis of prior P of root nodes) & conditional dependence on each node. Bwd: concerns the comp. Of posterier P of any given set of variables given some observtn
- Work on system safety and Bayesian Networks were developed by Kang & Venkatesk [1]
- In the paper [3] the authors describe the stochastic modelling techniques such as Fault Trees and Petri Net

Introduction contd...

- Bayesian networks have been applied mostly in the field of Artificial intelligence and now have gain popularity in the field of engineering decision strategy [8]
- It has not been used in the reliability analysis of Nuclear Power Plant structures

Bayesian networks

- acyclic graph that represents a joint probability distribution over a set of random variables V
- The network is defined by a pair $B = (G, \theta)$
- -G is the DAG whose nodes X₁,X₂,...,X_n represents random variables; edges represent direct dependencies between these variables.
- : set of parameters of the network. Set contains parameter $\theta_{x_i|\pi_i} = P_{\mathcal{B}}(x_i|\pi_i)$ for each $x_i \circ f(X_i)$ conditioned on π_i , the set of parents of X_i in G.
- B defines unique joint probability distribution over V

$$P_{B}(X) = P_{B}(X_{1}, X_{2}, ..., X_{n}) = \prod_{i=1}^{n} P_{B}(X_{i} | \pi_{i})$$
$$= \prod_{i=1}^{n} \theta_{x_{i} | \pi_{i}}(1)$$

Bayesian networks contd...

• The marginal probability of X_i is:

$$P(X_i) = \sum_{X \in X_i} P(X) \dots \dots \dots \dots \dots (2)$$

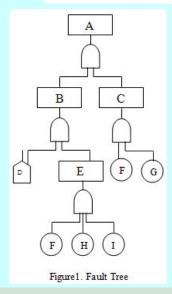
• Assuming an event E has occurred, we have:

$$P(X|E) = \frac{P(X,E)}{P(E)} = \frac{P(X,E)}{\sum_{X} P(X,E)} \dots \dots \dots \dots (3)$$

Bayesian networks contd...

 So, the joint probability of the Bayesian network, given in Figure 2 is:

P(X) = P(H)P(I)P(F)P(E|H,I,F)P(D)P(B|D,E) $\times P(G)P(C|F,G)P(A|B,C).....(4)$



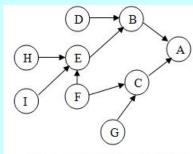


Figure 2. Bayesian Network of Figure 1

Bayesian networks contd...

The subsystem failure probability is:

$$P(A = 1) = \sum_{A=0}^{1} \sum_{B=0}^{1} ... \sum_{I=0}^{1} P(H)P(I)P(F)P(E|H,I,F)P(D)P(B|D,E) \times P(G)P(C|F,G)P(A = 1|B,C) (5)$$

Hence in case of subsystem failure, marginal probability of all the nodes in the network can be updated as: $P(X|A=1) = \frac{P(X,A=1)}{P(A=1)}.....(6)$

$$P(X|A=1) = \frac{P(X,A=1)}{P(A=1)}....(6)$$

Series system

■ A & B: 2 basic events

A	В
Pump1	Pump2

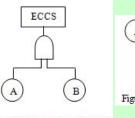




Figure 3. Fault Tree of ECCS

■ Here C is ECCS. Fig4 infers that A & B are independent

A	В	P(C=1 A, B)
0	0	0
0	1	1
1	0	1
1	1	1

Table 1. Probability of C failure given A & B in case

of series system
COUID ■ The dependence be the statistical correlation between the states of A and B due to the common random variables in their limit states.

- Hence $P(AB) \neq P(A)P(B) \dots (7)$
- We make 2 modifications:
- consider all the input random variables as root nodes. Eg. 5 strength of node i; applied load
 - failure probability $P(i) = f(S_i, \omega) \dots \dots \dots (9)$

■ Then we construct BN in case of correlated and uncorrelated variables

as:

Then we construct BN in case of correlated and uncorrelated variables as shown in Figure 5(a) and 5(b) respectively.

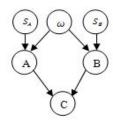


Figure 5a. Modified BN (not correlated variables)

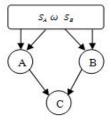


Figure 5b. Modified BN (correlated variables)

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- BN does not allow cycles but still can be created like figure5, by incorporating additional information on sequential failure probabilities as shown in Table2.
- Parallel Systems

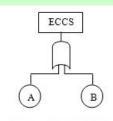


Figure6. Fault Tree of ECCS

A	В	P(C=1 A, B)
0	0	0
0	1	$P(A_B = 1 B=1, A=0)$
1	0	$P(B_A = 1 A=1, B=0)$
1	1	1

Table 2. Probability of C failure given A & B in case of parallel system

 A_B : updated state of A after B fails B_A : updated state of B after A fails

- Example P(C=1|A=1, B=0) = R(B_A = 1|A=1, B=0) means that the probability that C=1 will occur given A fails "first" is equal to B's failure probability given A fails "first", since C=1 is defined when both A & B fail.
- Through this construction of the conditional probability table for P(C=1|A,B), the problem of multiple failure sequences and the effect of failure of 1 pump on another can be solved in BN
- Hence, this approach allows modeling both types of dependence: statistical and sequential

■ So, the probability of ECCS function failure for series system (Fig3), using eq (1) & (2) is given as:

$$P(C=1) = \sum_{A=0}^{1} \sum_{B=0}^{1} \int_{s_A}^{\square} \int_{s_A}^{\square} \int_{\omega}^{\square} P(C=1|A,B)P(A|s_A,\omega) P(B|s_B,\omega) f(s_A)f(s_B)f(\omega) ds_A ds_B d\omega \dots \dots \dots (10)$$

- If these random variables are correlated, $f(s_s)f(s_s)f(\omega)$ needs to be replaced by their joint pdf.
- For clarification if suppose in case of series system, each node A and B takes half load, then following conditional probabilities can be used in equation: $\frac{P\left(A=1\left|s_{A}\leq\frac{\omega}{2}\right)=1\right)}{P\left(A=1\left|s_{A}\leq\frac{\omega}{2}\right)=1\right)}$

$$P\left(A=1\left|s_{A} \leq \frac{\omega}{2}\right)=1,\right.$$

$$P\left(A=0\left|s_{A} \geq \frac{\omega}{2}\right)=1\right.$$

$$P\left(B=1\Big|s_{z}\leq\frac{\omega}{2}\right)=1,$$

$$P\left(B=0\Big|s_{z}\geq\frac{\omega}{2}\right)=1$$

System Reliability & updation

- The equation 10 can be solved using multi-normal integration or Monte Carlo simulation without complete numerical integration
- Similarly in case of parallel system when one Pump A fails, other pump B can take the full load. We need to consider A_B and B_A

So

$$P(C=1) = P(C=1|A=1,B=1)P(A=1,B=1) + P(C=1|A=0,B=1)P(A=0,B=1) + P(C=1|A=1,B=0) \times P(A=1,B=0) + P(C=1|A=0,B=0)P(A=0,B=0)$$

$$= P\left(s_{A} \leq \frac{\omega}{2} \cap s_{B} \leq \frac{\omega}{2}\right) + P\left(s_{A} \leq \omega \middle| s_{A} \geq \frac{\omega}{2} \cap s_{B} \leq \frac{\omega}{2}\right) \times P\left(s_{A} \geq \frac{\omega}{2} \cap s_{B} \leq \frac{\omega}{2}\right) + P\left(s_{B} \leq \omega \middle| s_{A} \leq \frac{\omega}{2} \cap s_{B} \geq \frac{\omega}{2}\right) \times P\left(s_{A} \leq \frac{\omega}{2} \cap s_{B} \geq \frac{\omega}{2}\right).$$

$$=P\left(s_{_{A}}\leq\frac{\omega}{2}\cap s_{_{B}}\leq\frac{\omega}{2}\right)+P\left(s_{_{A}}\leq\omega\cap s_{_{A}}\geq\frac{\omega}{2}\cap s_{_{B}}\leq\frac{\omega}{2}\right)+P\left(s_{_{B}}\leq\omega\cap s_{_{A}}\leq\frac{\omega}{2}\cap s_{_{B}}\geq\frac{\omega}{2}\right).$$

■ Failure probability using Fault Tree approach is given by considering the same failure sequence:

$$A \to B \equiv s_{_{A}} \le \frac{\omega}{2} \cap s_{_{B}} \le \omega$$
$$B \to A \equiv s_{_{B}} \le \frac{\omega}{2} \cap s_{_{A}} \le \omega$$

Hence

$$\begin{split} P(C=1) &= P(A \to B) \cup P(B \to A) \\ &= P\left[\left(s_{_{A}} \leq \frac{\omega}{2} \cap s_{_{B}} \leq \omega\right) \cup \left(s_{_{B}} \leq \frac{\omega}{2} \cap s_{_{A}} \leq \omega\right)\right] \\ &= P\left[\left(s_{_{A}} \leq \frac{\omega}{2} \cap \left(s_{_{B}} \leq \frac{\omega}{2} \cup \left(\frac{\omega}{2} \leq s_{_{B}} \cap s_{_{B}} \leq \omega\right)\right)\right) \cup \left(s_{_{B}} \leq \frac{\omega}{2} \cap \left(s_{_{A}} \leq \frac{\omega}{2} \cup \left(\frac{\omega}{2} \leq s_{_{A}} \cap s_{_{A}} \leq \omega\right)\right)\right)\right] \end{split}$$

$$=P\left[\left(s_{_{A}}\leq\frac{\omega}{2}\cap s_{_{B}}\leq\frac{\omega}{2}\right)\cup\left(s_{_{A}}\leq\frac{\omega}{2}\cap\frac{\omega}{2}\leq s_{_{B}}\cap s_{_{B}}\leq\omega\right)\cup\left(s_{_{B}}\leq\frac{\omega}{2}\cap\frac{\omega}{2}\leq s_{_{A}}\cap s_{_{A}}\leq\omega\right)\right].................(14)$$

■ These 3 events are mutually exclusive, so

■ Equation 13(BN) and 15(traditional) are identical

Reliability updation

■ If ECCS failure is observed, in case of series system; failure probability of A & B and probability distribution of random variable can be updated as:

$$P(A = 1 | C = 1) = \frac{P(A = 1, C = 1)}{P(C = 1)} = \frac{P(A = 1)}{P(C = 1)} = \frac{P(S_A \le \frac{\omega}{2})}{P(C = 1)}$$

$$P(B = 1 | C = 1) = \frac{P(B = 1, C = 1)}{P(C = 1)} = \frac{P(B = 1)}{P(C = 1)} = \frac{P(S_A \le \frac{\omega}{2})}{P(C = 1)}$$

$$f(S_A | C = 1) = \frac{dF(S_A | C = 1)}{dS_A} = \frac{d}{dS_A} \left(\frac{P(S_A \le S_A, C = 1)}{P(C = 1)}\right)$$

 $f(s_{A}|C=1) = \frac{dF(s_{A}|C=1)}{ds_{A}} = \frac{d}{ds_{A}} (\frac{P(s_{A} \le s_{A}, C=1)}{P(C=1)})$ ■ P(C=1) can be calculated from equation 10. Similarly distribution of other variables can be found out. If B failure is observed, other nodes can be updated as:

$$P(A = 1, B = 1) = \frac{P(A = 1, B = 1)}{P(B = 1)}$$

$$f(s_{g}|B = 1) = \frac{dF(s_{g}|C = 1)}{ds_{g}} = \frac{d}{ds_{g}} \left(\frac{P(S_{g} \le s_{g}, B = 1)}{P(B = 1)} \right)$$

$$P(C = 1, B = 1) = \frac{P(C = 1, B = 1)}{P(B = 1)} = \frac{P(B = 1)}{P(B = 1)} = 1$$

Reliability updation

Similarly for parallel system

$$\begin{split} P(C=1,B=1) &= \frac{P(C=1,B=1)}{P(B=1)} = \\ &= \frac{P(C=1|A=0,B=1) \times P(A=0,B=1)}{P(B=1)} \\ &= \frac{P(C=1|A=1,B=1) \times P(A=1,B=1)}{P(B=1)} \\ &= \frac{P\left(S_A \leq \omega \cap S_A \geq \frac{\omega}{2} \cap S_B \leq \frac{\omega}{2}\right) + P\left(S_A \leq \frac{\omega}{2} \cap S_B \leq \frac{\omega}{2}\right)}{P\left(S_B \leq \frac{\omega}{2}\right)} \end{split}$$

■ All the joint probabilities, mentioned in the above equations may be obtained by Monte Carlo simulation.

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Integrated communication – present and future possibilities

Unifying security and safety communication over IP infrastructure



Background - Past



- Analogue/digital solutions
- Proprietary solutions offered limited integration
- Cabling tailored to use



Background - Present



- Networked solutions becoming available on most platforms
- Integrated solutions desired/required
- Ethernet/structured cabling more widespread



Industrial buses on Ethernet







Structured cabling



- Common cabling scheme
- Cat. 5 (or better) cabling
- Power distribution (PoE or PoE+)



Structured cabling



- Flexible and unified infrastructure
- Future-proof
- Compatible with analogue and IP systems



Where are we today?

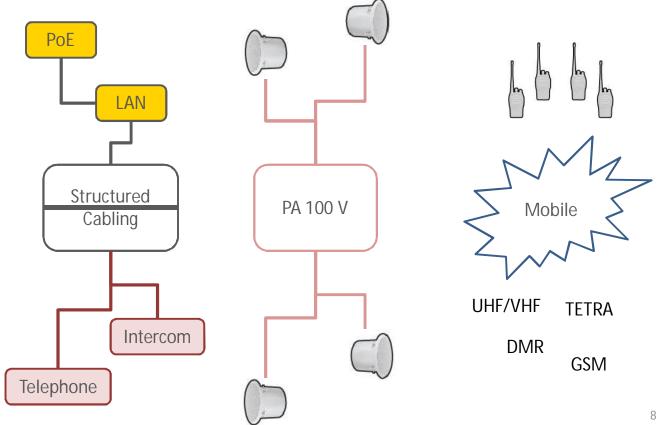


- A lot of systems share common distribution infrastructure (structured cabling)
- Still individual and proprietary platforms
- Standardization is increasing



Modern infrastructure

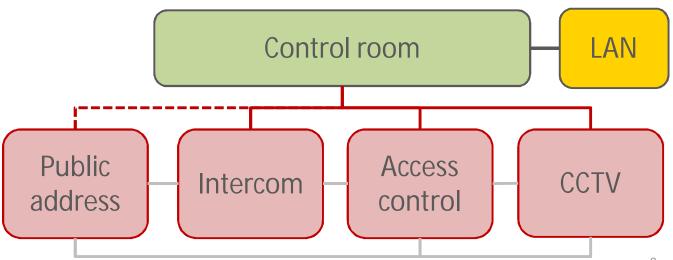






Traditional Com/Sec system



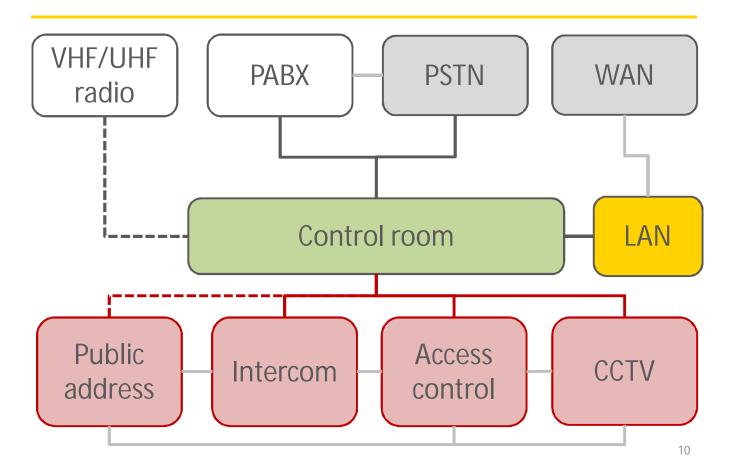


9



Traditional Com/Sec system







Traditional Com/Sec systems

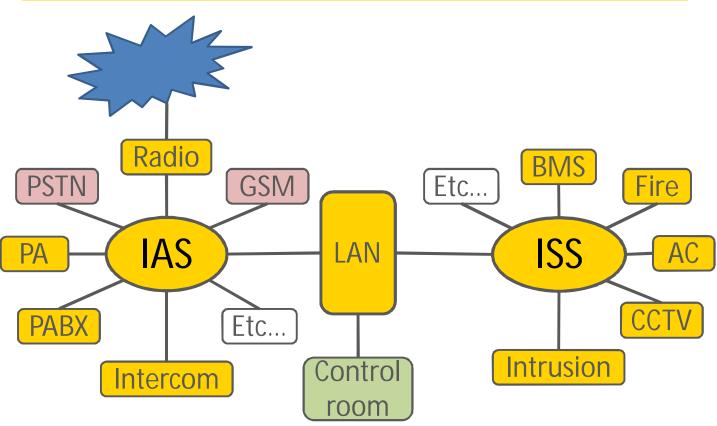


- Dispatch/Control-room acts as hub
- Low level of integration
- Analouge communication dominates



Integrated Com/Sec system



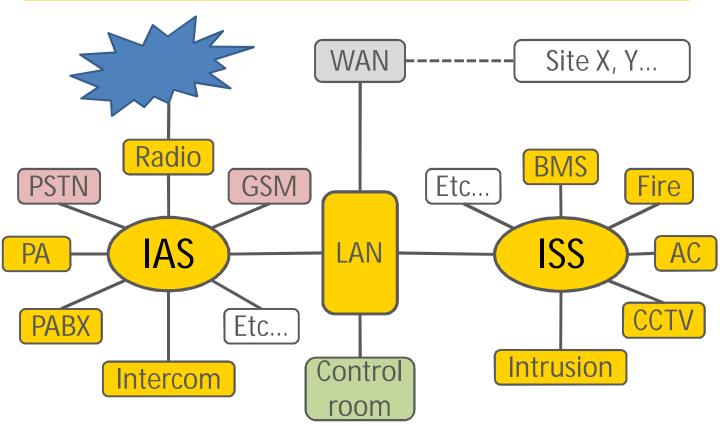


12



Integrated Com/Sec system





13



Benefits - Financial



- Reusing existing infrastructure
- Increased utilization of human resources
- Distributed systems + Unified cabling = less investment and maintenance cost



Benefits - Operational



- Automation = Reduced response time in case of an undesired event
- Automation = Reduced risk of human error
- Integration = increased capability of exisitng systems



Benefits - Maintenance



- Redundancy = reduced down-time = less maintenance
- No custom-made or obsolete physical interfaces
- Networked solutions permits remote configuration, diagnostics and SW maintenance



Benefits - Flexibility



- Common protocols = Less chance of tie-in to a single provider
- Infrastructure may be repurposed should needs change
- Ethernet = Scalability and modularity



Future



- More integration / virtualisation
- User experience / user friendliness
- Virtual interfaces / Touch-screen





Thank you



Background - Platforms



SCADA (LAN)				
Application platform (LAN) PCs Peripherals Data Storage App Servers				
Security platform CCTV BMS Access Fire				
Communications platform Telephony Mobile Intercom Public Address				



Background - Platforms



SCADA LAN

Application LAN				
PCs	Peripherals	Data Storage	App Servers	

Communication, Safety and Security LAN				
CCTV	BMS	Access	Fire	
Telephony	Mobile	Intercom	Public Address	





NEW High Sensitivity Single Beam Infrared Gas Analyzers



□ Conclusion

Agenda



Introduction – Basics of NDIR Principle
 Analyser Types Dual beam vs. Single Beam
 New Series of High Sensitivity Single Beam Analyser
 Basic Configuration
 Technical advantages
 Enhanced Sensitivity
 Ease of Use
 Cancellation of Zero Point Drift
 Small Size
 Compact Internals
 Abundant Features
 Technical Specifications Comparison

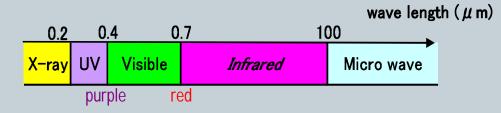


Non Dispersive Infrared Principle Fuji Electric



1) What is Infrared ray?

Part of electro magnetic wave of which wave length is longer than visible "red".



2 Molecules absorb Infrared energy at it's own wave length.

Magnitude of absorption is proportional to the product of gas concentration and path length = Lambert - Beer's Low



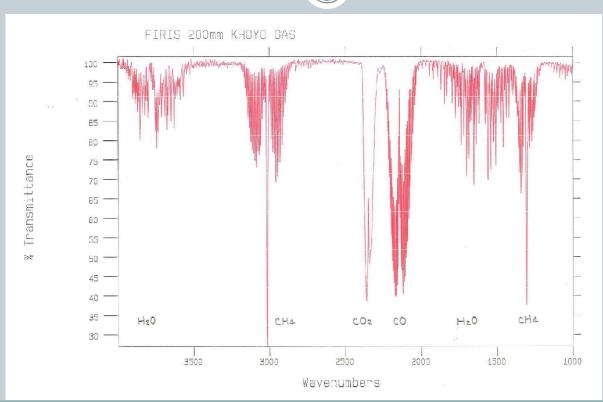
We can determine the gas concentration by measuring intensity of Infrared energy



Infrared Absorbance spectra



4

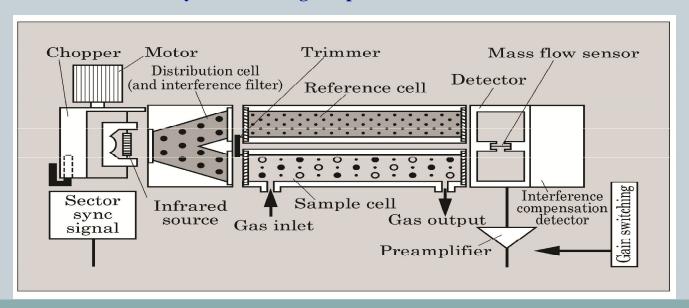




Dual Beam NDIR Type



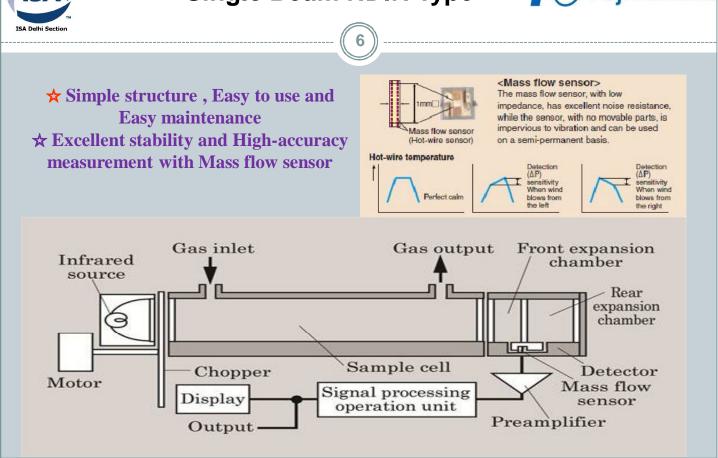
- **★** High accuracy measurement in low concentration
- **★** Measurement with high sensitivity Mass flow sensor
- **★**Minimum cross sensitivity with **Dual detector** system
- **★** Flexibility for measuring components





Single Beam NDIR Type

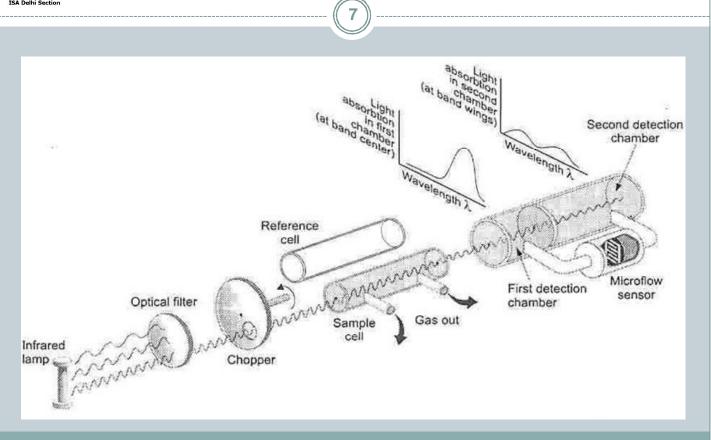






Single Beam NDIR Principle Fuji Electric







New Series Analysers



General use model

Min. measuring range: 0 to 200ppm NO/SO2/CO

0 to 100ppm CO2

Applications: Incinerator Combustion Control, Hot Oven , Boiler Combustion Control, Cement Plant Process Monitoring, Emission Monitoring, Furnace Monitoring

High performance model with Sample Switching

Min. measuring range: 0 to 50ppm NO/SO2/CO/CO2

Applications: Waste Incineration Emission Monitoring, Gas Fired Power Plants Emission Monitoring, Steel Plant Exhaust Gas Monitoring



Min. measuring range : 0 to 5 ppm CO/CO2 0 to 10 ppm NO/SO2

Applications: Gas Supply Product Monitoring, Impurity Monitoring, Air Quality Measurement, Green house Gas Global Warming monitoring





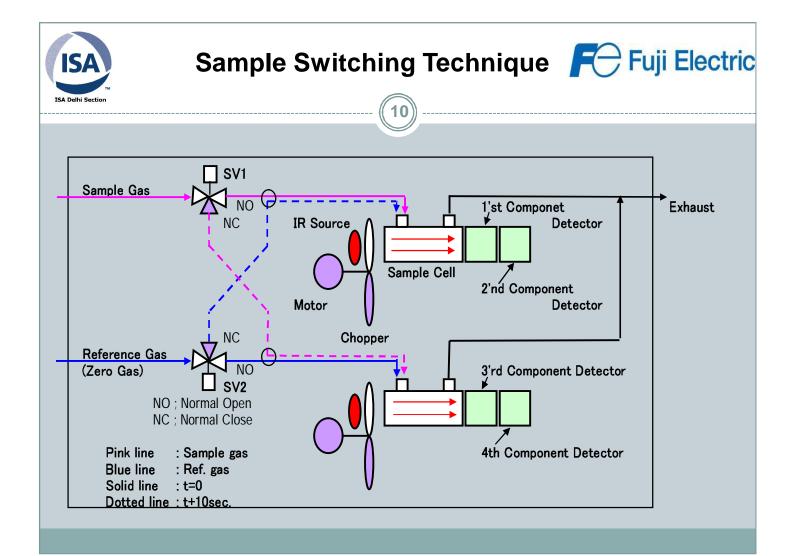




ZP Series Single Beam Type Fuji Electric



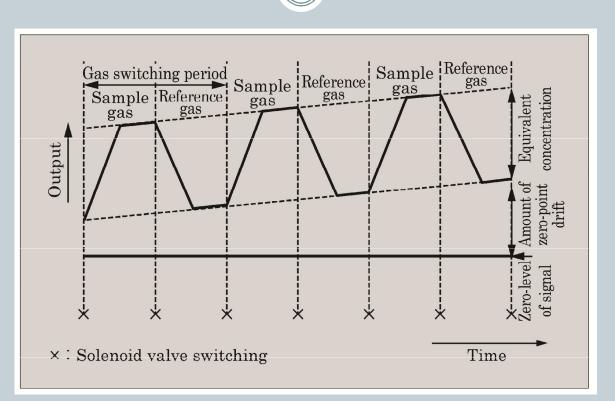
- Enhanced sensitivity of Mass Flow Sensor
 - State of the art design & manufacturing process realized 2 times higher S/N than current sensor
 - Durable construction with moving parts enables resistance to vibration
 - Low impedance enables high S/N and resistant to noise
- Multi layer detectors assures
 - Minimum cross-sensitivity to coexistence gases
 - **Measurement with High stability**
- Easy to maintain & Easy to use menu driven with large LCD
 - Robust single beam system requires no optical adjustment
- **■** Barometric pressure compensation available
 - Supports correction for transient weather disturbances





Cancellation of Zero point Drift For Fuji Electric



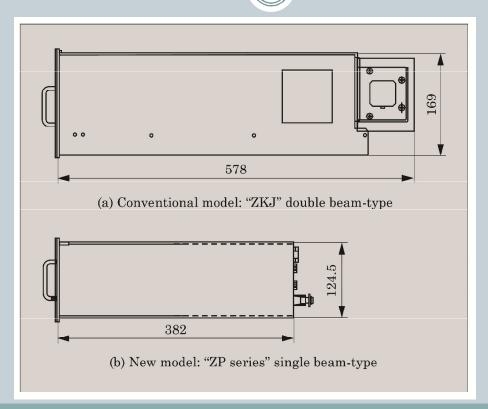




Small Size Easy to Handle







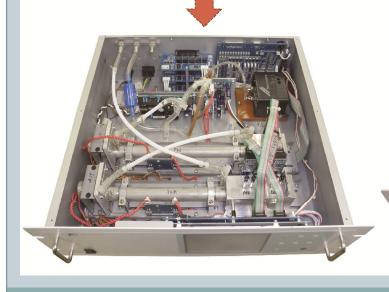


Compact Internals



General Use Model Compact & Ease of Use

High Performance Model With Sample Switching







Abundant Features



(14

- Output Range Hold
- Range Switching (Automatic/ Manual)
- Range Identification Contact Output
- RS-485 Communication and Analog and Digital Outputs
- Auto Calibration (+Remote Start) with Calibration Status Contact
- O2 Correction output
- Upper / Lower Limit Alarm Contact Output
- Instrument failure Contact Output
- Calibration Error Contact Output
- CO Peak Alarm Output
- Atmospheric Pressure Correction
- Average Value Reset Contact Input



Technical Specifications Comparison F Fuji Electric



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Model		ZPA	ZPB	ZPG	
Measuring Principle		Non-Di	ispersive Infrared absorp	otion	
Measuring Method		Single Beam	Single Beam Sample Swiching		
Measurable Components	· ·		NO, SO2, CO, CO2		
	NO	0 to 200 ppm	0 to 50 ppm	0 to 10 ppm	
	SO2	0 to 200 ppm	0 to 50 ppm	0 to 10 ppm	
Minimun Measuring Range	CO	0 to 200 ppm	0 to 50 ppm	0 to 5 ppm	
	CO2	0 to 100 ppm	0 to 20 ppm	0 to 5 ppm	
	CH4	0 to 500 ppm	-	-	
Range Ratio		Up to 1 : 10			
Repeatability		Better than \pm 0.5% of Full Scale (*Note1)			
Linearity		Better than \pm 1% of Full Scale			
Zero Drift		Less than \pm 2% FS /week	Less than repeatability		
		(*Note2)			
Span Drift		Less than $\pm 2\%$ FS /week			
Response time		Less than 10 sec.	Less than 30 sec.		
Dimensions		133H x 483W x 448D mm			
Measuring Range Compatible Current Model		ZRE (Single Beam)	ZKJ (Double Beam)	None	

(*Note 1) For measuring range < 200ppm, Better than \pm 1%FS

(*Note 2) Using auto zero calibration for measuring range < 500ppm



Conclusion



(16)

- Small Size High Sensitivity measurement
- Simple Maintenance due to Single Beam Design
- No zero drift Sample gas and zero gas are switched per 10 seconds to compensate zero point
- S/N ratio is improved more than 4 times than standard single beam with state of the art signal processing technique
- Using Sample Switching method and State of the Art Signal Processing allows for stable low- concentration measurement just like in Traditional Dual Beam Analyzers
- Supports a Wide Range of Measurements for different applications



Thank You







Sanjeev Kumar Gupta Director & CEO Analyser Instrument Co. Pvt. Ltd. www.aicplindia.com











Advanced microwave technology to measure unburned carbon in ash

- Non-extractive monitoring measures carbon across the width of the back-pass.
- Real-time monitoring provides data that enables easy integration into Combustion Optimization systems.
- A simple design, with minimal moving parts, provides fast installation and less maintenance.



Carbon In Ash Measurement –Advantages



Increased !!!



- Increased combustion efficiency
- Increased quality of Fly Ash resulting in better sale price!
- Improved Mercury capture
- Loss of Ignition availability
- Balanced plant efficiency



- Reduced operating cost
- Reduced amount of Fly Ash & reduced Land Filling
- Reduced manual LOI procedure

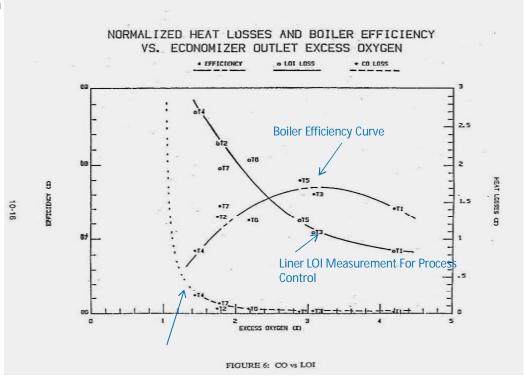
Reduced !!!



Carbon In Ash Measurement LOI – Excellent Measure of Efficiency



- LOI is a measure of Carbon in Fly Ash
- CIA helps in optimizing boiler efficiency through real time measure of Carbon in Ash (LOI)
- LOI responds to efficiency loss much sooner than CO



Non-linear & low sensitivity CO measurement, unsuitable for process control

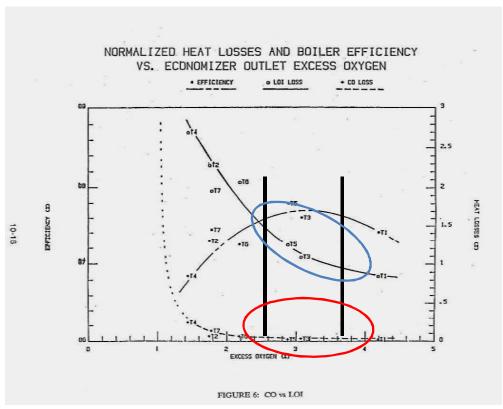
Source Land Combustion, Ken Greaves

© ABB Inc. October 18, 2013 | Slide 4



Carbon In Ash Measurement LOI – Excellent Measure of Efficiency





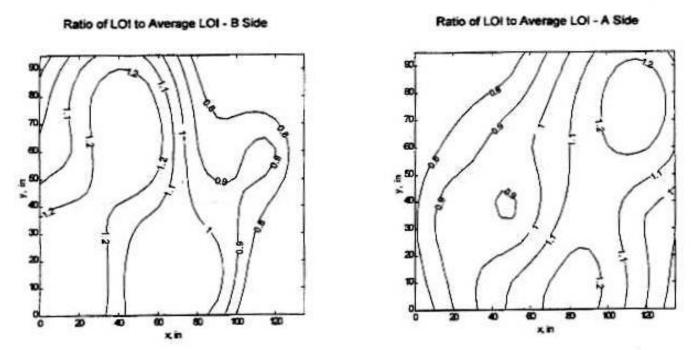
•LOI is much more linear than CO, so you can control the process from this signal

•LOI responds to efficiency loss much sooner than CO.





Accuracy problems with duct sampling



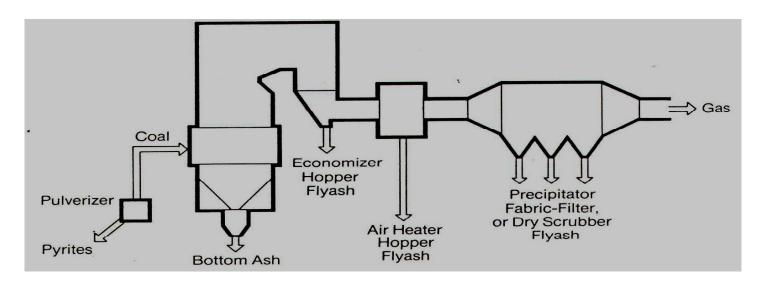
Typical Gas Distribution In Exit Gas Outlet Duct: 40% Variation Across Width of Unit







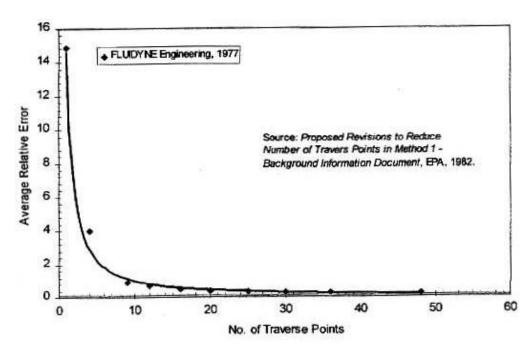
- •Ash Hopper Deposits Vary As A Function Of:
 - •Unit Load
 - •Carbon Content in Ash
 - •Ash w/ Carbon ~ 35 65 # / ft³
 - •Ash w/o Carbon ~ 90 180 # / ft3







Accuracy problem with duct sampling



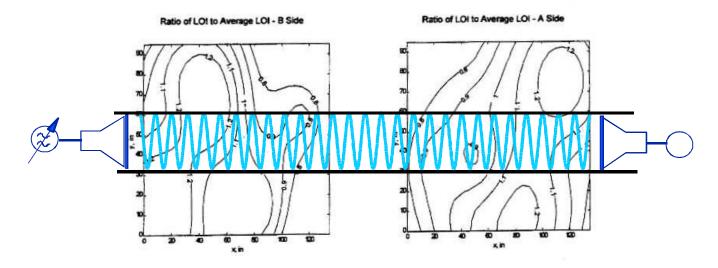
Due to Gas Distribution Within The Duct,

Upwards Of 20 Extractive Taps May Be Required



Accuracy Problems With Duct Sampling





Duct Gas / LOI Stratification Is Not a Problem When Instrument Is Not Dependent On Point Sampling